

### STL60NH3LL

# N-channel 30V - 0.0065Ω - 30A - PowerFLAT<sup>™</sup> (6x5) Ultra low gate charge STripFET<sup>™</sup> Power MOSFET

#### **General features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STL60NH3LL	30V	<0.0085Ω	16A <sup>(2)</sup>

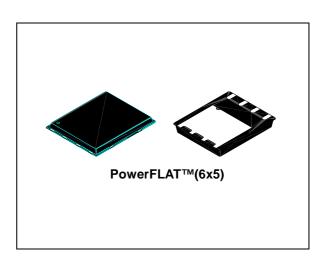
- Improved die-to-footprint ratio
- Very low profile package (1mm max)
- Very low thermal resistance
- Very low gate charge
- Low threshold device

### **Description**

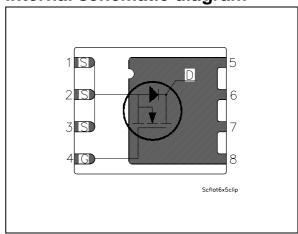
This application specific Power MOSFET is the latest generation of STMicroelectronics unique "STripFET™" technology. The resulting transistor is optimized for low on-resistance and minimal gate charge. The Chip-scaled PowerFLAT™ package allows a significant board space saving, still boosting the performance.

### **Applications**

Switching application



### Internal schematic diagram



### **Order codes**

Part number	Marking	Package	Packaging	
STL60NH3LL	L60NH3LL	PowerFLAT™ (6 x 5)	Tape & reel	

Contents STL60NH3LL

## **Contents**

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuit
4	Package mechanical data
5	Revision history

STL60NH3LL Electrical ratings

# 1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	30	V
V <sub>GS</sub>	Gate-source voltage	± 16	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	30	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100°C	30	Α
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	16	Α
I <sub>DM</sub> <sup>(3)</sup>	Drain current (pulsed)	64	Α
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at T <sub>C</sub> = 25°C	60	W
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at T <sub>C</sub> = 25°C	4	W
	Derating factor	0.03	W/°C
T <sub>j</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

<sup>1.</sup> The value is rated according  $R_{\text{thj-C}}$  and is limited by wire bonding.

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case (drain) Max	2.08	°C/W
Rthj-pcb (1)	Thermal resistance junction-pcb Max	31.3	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1inch<sup>2</sup>, 2 oz Cu, t<10sec

<sup>2.</sup> This value is according  $R_{\text{thj-pcb}}$ 

<sup>3.</sup> Pulse width limited by safe operating area

Electrical characteristics STL60NH3LL

# 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250\mu A, V_{GS} = 0$	30			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating,@125°C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>DS</sub> = ± 16V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS}$ = 10V, $I_{D}$ = 8A $V_{GS}$ = 4.5V, $I_{D}$ = 8A		0.0065 0.0075	0.0085 0.0105	Ω

Table 4. Dynamic

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS}$ =25V, f = 1MHz, $V_{GS}$ =0		1810 565 41		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ = 15V, $I_{D}$ = 16A, $V_{GS}$ = 4.5V (see Figure 15)		18 4.8 5.3	24	nC nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain	0.5	1.5	3	Ω

Table 5. Switching times

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time Rise time	$V_{DD}$ = 15V, $I_D$ = 8A $R_G$ = 4.7 $\Omega$ , $V_{GS}$ = 10V, (see Figure 14)		8 65		ns ns
t <sub>d(off)</sub>	Turn-off delay time Fall time	$V_{DD}$ = 15V, $I_D$ = 8A $R_G$ = 4.7 $\Omega$ , $V_{GS}$ = 10V, (see Figure 14)		30 20		ns ns

Table 6. Source drain diode

Symbol	Parameter	Test condictions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current Source-drain current (pulsed)				16 64	A A
V <sub>SD</sub> <sup>(1)</sup>	Forward on voltage	I <sub>SD</sub> = 16A, V <sub>GS</sub> = 0			1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 16V, di/dt = 100A/ $\mu$ s $V_{DD}$ = 20V, $T_j$ = 25°C (see Figure 16)		22 32 1.9		ns nC A

<sup>1.</sup> Pulsed: Pulse duration = 300µs, duty cycle 1.5%

**577** 

Electrical characteristics STL60NH3LL

### 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

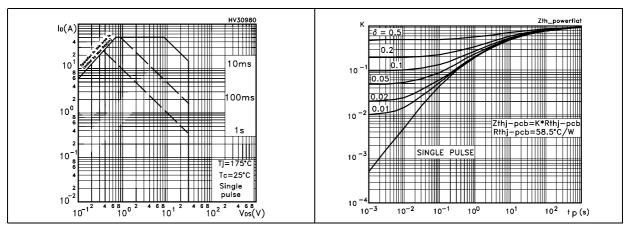


Figure 3. Output characterisics

Figure 4. Transfer characteristics

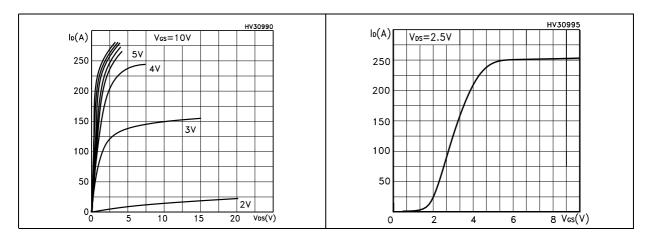
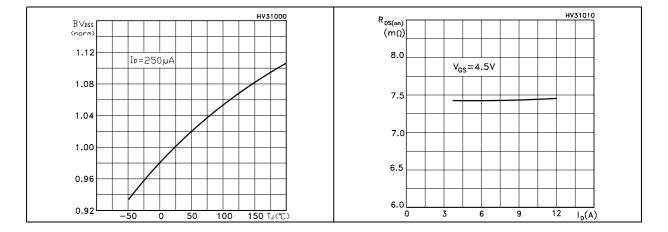


Figure 5. Normalized B<sub>VDSS</sub> vs temperature

Figure 6. Static drain-source on resistance



6/13

Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

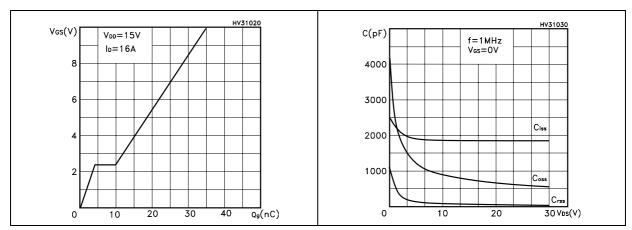


Figure 9. Normalized gate threshold voltage Figure 10. vs temperature

Figure 10. Normalized on resistance vs temperature

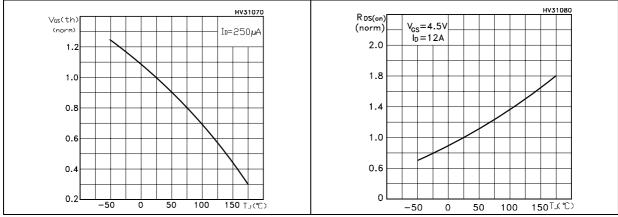
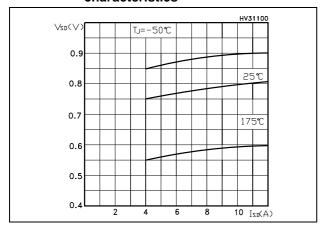
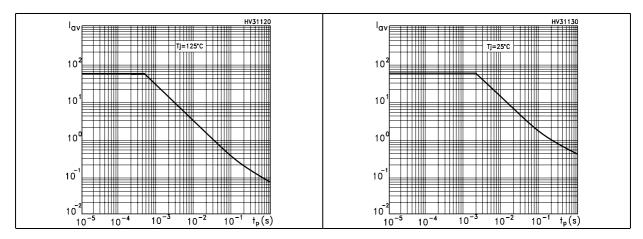


Figure 11. Source-drain diode forward characteristics



Electrical characteristics STL60NH3LL

Figure 12. Allowable lav vs Time in Avalanche Figure 13. Allowable lav vs Time in Avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads under the following conditions:

$$P_{D(AVE)} = 0.5*(1.3*BV_{DSS}*I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} *t_{AV}$$

Where:

I<sub>AV</sub> is the allowable current in avalanche

P<sub>D(AVE)</sub> is the average power dissipation in avalanche (single pulse)

t<sub>AV</sub> is the time in avalanche

STL60NH3LL Test circuit

### 3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

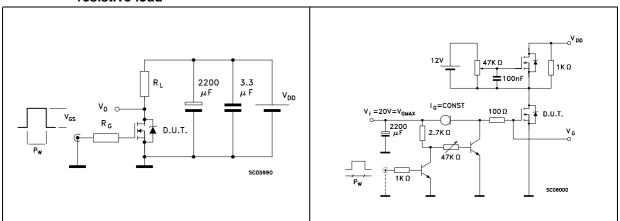


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

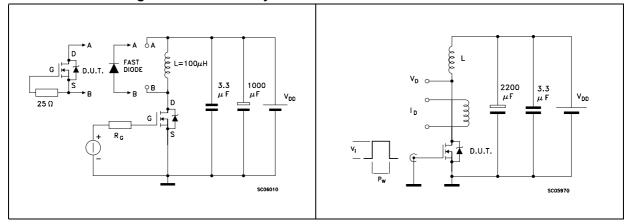
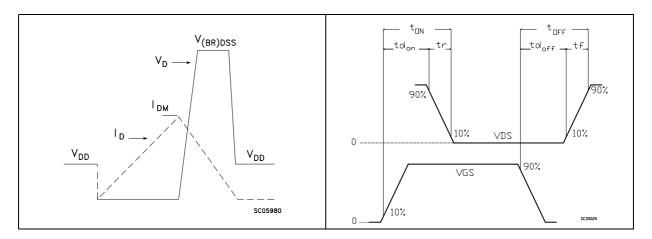


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform

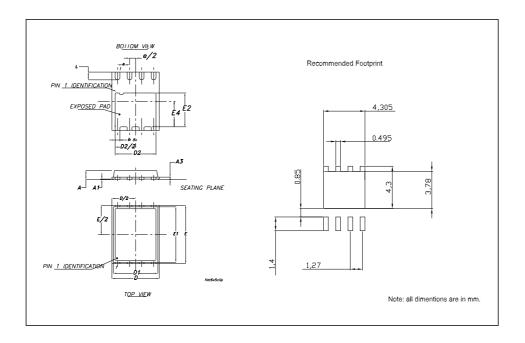


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

### PowerFLAT™ (6x5) MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
Е		6.00			0.236	
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
е		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035



5/

Revision history STL60NH3LL

# 5 Revision history

Table 7. Revision history

Date	Revision	Changes
21-Jul-2004	1	First Release
05-Oct-2004	2	Values Changed
12-Apr-2006	3	New template

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